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Infrared plasmons in ultrahigh conductive PdCoO₂ metallic oxide

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PdCoO $_2$ layered delafossite is the most conductive compound among metallic oxides, with a room-temperature resistivity of nearly $2\,\mu\Omega\,\mathrm{cm}$, corresponding to a mean free path of about 600 Å. These values represent a record considering that the charge density of PdCoO $_2$ is three times lower than copper. Although its notable electronic transport properties, PdCoO $_2$ collective charge density modes (i.e. surface plasmons) have never been investigated, at least to our knowledge. In this paper, we study surface plasmons in high-quality PdCoO $_2$ thin films, patterned in the form of micro-ribbon arrays. By changing their width W and period W0, we select suitable values of the plasmon wavevector W0, experimentally sampling the surface plasmon dispersion in the mid-infrared electromagnetic region. Near the ribbon edge, we observe a strong field enhancement due to the plasmon confinement, indicating PdCoO $_2$ as a promising infrared plasmonic material.

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urface plasmons, the collective oscillations of electrons in metals and doped semiconductors, show outstanding electromagnetic (EM) properties spanning from a reduced wavelength in comparison to that of an exciting electromagnetic field, an extreme local electric field enhancement several orders of magnitude larger than the incident em field, to several nonlinear effects like harmonic generation and optical rectification¹. Those properties are the basis of nano-infrared and surface-enhanced Raman spectroscopies, currently applied in many bio-sensing techniques¹⁻⁴. Although conventional metals, like gold and silver, are usually used in plasmonics¹, non-conventional conductors like graphene⁵⁻⁷, transparent oxides⁸, high-Tc superconductors^{9,10}, strongly-correlated oxides^{11–13}, and topological materials^{14–16} are now on the scientific edge, providing additional properties like plasmon tunability due to their extreme sensitivity, to external parameters like doping, temperature, and electric and magnetic fields¹⁷. Among metallic oxides, PdCoO₂ layered delafossite is the most conductive, having a room-temperature resistivity of nearly $2 \mu\Omega$ cm, corresponding to a mean free path of about 600 Å 18,19 . These values are comparable to those of the best three-dimensional (3D) metallic conductors such as Al, Au, Cu, and Ag, although the charge density of PdCoO₂ is ~30% the copper one. PdCoO₂ has a nearly two-dimensional (2D) layered structure composed of Pd triangular layers and CoO₂ slabs¹⁸. Theories^{20–23} and experiment²⁴ show that the electronic density of states at the Fermi level is dominated by Palladium indicating that the electronic states are nearly 2D. Its single-particle electrodynamics has been measured on single crystals²⁵ and it is dominated at Infrared (IR) and Terahertz (THz) frequencies by intraband excitations, well described by the Drude model, while interband transitions appear above 8000 cm⁻¹ (1 eV). Although the very long mean free path at room temperature, and the nearly perfect separation between intra- and interband electronic transitions provide an ideal framework for investigating the collective electronic excitations (surface plasmons) of PdCoO₂ layered delafossite, these modes have never been measured to our knowledge.

Here, we report experimental evidence of surface plasmonic excitations in thin films of PdCoO₂ on sapphire substrates. In particular, we have fabricated parallel ribbons array structures of PdCoO₂ and investigated their optical properties from THz to Visible (VIS) for light polarization parallel and perpendicular to the ribbons. When the polarization is perpendicular to the ribbon array, one excites plasmon modes at the surface of the PdCoO₂ film. Through the measurements of several ribbon arrays, we have sampled the plasmon frequency *vs.* wavevector, being able to experimentally determine the energy/momentum dispersion of surface plasmons in PdCoO₂.

Results and discussion

Five 100 nm films of palladium-cobalt delafossite were grown by molecular beam epitaxy (MBE) on 500 μm thick Al_2O_3 substrates 26 (see Methods). The reflectance $R(\omega)$ of an as-grown film was measured across the THz to ultraviolet (UV) spectral range with a Fourier-transform Michelson interferometer (THz-IR) and a near-infrared (NIR)-UV spectrophotometer. $R(\omega)$ spectrum (Fig. 1a), shows a Drude-like behavior at THz and Mid-IR (MIR) frequencies, while hosting interband features in the NIR-UV range, in agreement with the previous bulk characterization of this material 25 . $R(\omega)$ spectra have been analyzed through the RefFit program 27 , taking into account the optical properties of the sapphire substrate measured in the same experimental conditions. The bare PdCoO2 reflectance (as extracted from RefFit fitting) is represented in the inset of Fig. 1a, showing a value around 1 from THz to MIR. Using the f-sum rule (see "Methods"), we obtain a plasma frequency of $16800\pm300\,\mathrm{cm}^{-1}$. This value is nearly two

times lower than the bulk one²⁵ in agreement with the decrease of the material conductivity in thin films²⁶.

Micro-ribbon arrays (Fig. 1b) of different widths W and periods 2W have been fabricated through electron lithography (see Methods), to select suitable values of the plasmon wavevector a, so that a series of discrete values of $q = \pi/W$ were obtained. In Fig. 1b we show a Scanning Electron Microscope (SEM) image for the W =1 µm patterned film, while in Fig. 1d, the optical images of all patterned films are reported. Plasmon excitations have been studied by measuring the reflectance of patterned samples for light polarization perpendicular to the ribbons (Fig. 1c) and comparing them to those with opposite polarization (Fig. 1c). When the electric field is parallel to the ribbons, one measures the Drude response of the film+substrate renormalized by the patterning. This is particularly evident for the $W = 5 \,\mu \text{m}$ pattern, where one clearly observes the main sapphire phonon located around 600 cm $^{-1}$. This phonon is progressively shielded by the metallic response of the film for decreasing W. At W=500 nm, a reflectance resembling that of the unpatterned film is finally reached. Plasmonic excitations are generated at the interface between a metal and a dielectric and, for the metallic films here considered, two different surface plasmons are expected: one at the interface between the PdCoO₂ metal and sapphire substrate, and a second between metal and air (or vacuum)²⁸. These modes can be excited when the electric field is perpendicular to the ribbons, appearing in the reflectance as a dip in an otherwise flat metallic response^{28,29}. In our case, one indeed observes two peaks separated by a dip (see black arrows in Fig. 1c) in all patterned films, followed by a broader minimum. Although the second spectral feature is broader and then less visible in the experimental reflectances than the first one, both shift to higher frequencies as expected for an increasing plasmon wavevector $q = \pi/W$. In order to better highlight the plasmonic absorption, we subtract from the reflectances in Fig. 1c, both the sapphire phonon contribution below $\sim 1000~{\rm cm}^{-1}$ and the high-frequency background above ~7000 cm⁻¹. This background is practically independent of patterning and polarization coming by high-frequency intrinsic electronic interband transitions of PdCoO₂. The results are finally shown in Fig. 2, where we plot all plasmon excitations at different W. From this figure, the plasmon absorptions in patterned PdCoO₂ as well as and their hardening vs. $q = \pi/W$ are fully evident. A comparison among plasmonic experimental data, electromagnetic simulations and an analytical model allows us to assign the low-frequency dips to plasmons living at the PdCoO₂-sapphire interface, while the high-frequency broad minima to plasmons at the PdCoO₂-air interface. These assignments have been obtained by two different methods. In the former we simulate reflectance curves of patterned films through the COMSOL electromagnetic simulation program (see Methods), using as input the experimental conductivity of PdCoO₂ unpatterned film. Simulated R(ω) for light polarization perpendicular to the ribbon array are represented (red lines) in Fig. 3a for the $W = 2 \mu m$ sample and in Fig. 3b for the $W = 1 \,\mu\text{m}$, respectively. They are in very good agreement with experimental data (blue lines). Simulations have been performed also for a patterned self-standing PdCoO2 film (PdCoO2-air interface), showing that the broad feature, observed in Fig. 3 at a higher frequency with respect to the dip, is related to plasmons at the same interface (see Supplementary Methods II). In the second approach, we model the Fresnel reflection coefficient of the PdCoO₂ film on sapphire through a thin film approximation

$$r(\omega) = \frac{(\varepsilon_s(\omega)q_{\perp} - q'_{\perp} + \sigma_f(\omega)dZ_0q'_{\perp})}{(\varepsilon_s(\omega)q_{\perp} + q'_{\perp} + \sigma_f(\omega)dZ_0q'_{\perp})}$$
(1)

where $\varepsilon_s(\omega)$ and $\sigma_f(\omega)$ are the dielectric function of sapphire or air, and the optical conductivity of the PdCoO₂ film, respectively. d is the thickness of the film ($d = 100 \, \mathrm{nm}$ in our case), $Z_0 = 377 \, \Omega$ is

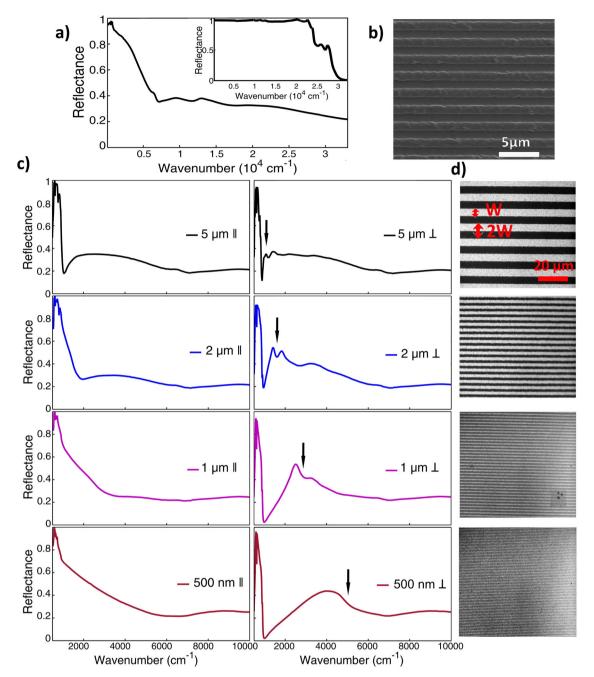


Fig. 1 Reflectance of unpatterned and patterned PdCoO₂ thin films on sapphire. **a** Reflectance of the as-grown, unpatterned film of PdCoO₂. The inset in the right upper side shows the bare reflectance of PdCoO₂ extracted through RefFit program. **b** Scanning electron microscope (SEM) image of the $W=1~\mu m$ patterned film. The bar-size is 5 μ m. **c** Reflectance of the four patterned films, with the radiation electric field parallel to the ribbons (left column) and perpendicular to the ribbons (right column). Arrows indicate approximately the frequency location of surface plasmon excitations. **d** Optical microscope images of the four patterned films with different widths W and periods 2 W. All the images have the same dimensions. Brighter parts are related to the oxide film, while darker regions are associated to the sapphire substrate.

the impedance of free space, and q_{\perp} and q'_{\perp} are the incident and transmitted (inside the film) wavevectors of the light, perpendicular to the film surface.

Since the light polarization is perpendicular to the ribbon array, the transmitted light wavevector acquires an additional longitudinal wavevector $q'_{\parallel}=\pi/W$ due to the pattern³⁰. The normal incident light has thus a wavevector $q_{\perp}=q_0=\omega/c$, while its transmitted component $q'_{\perp}=\sqrt{\varepsilon_s(\omega)q_0^2-q'_{\parallel}^2}$, with $q'_{\parallel}=\pi/W$. This model is valid as long as the incident light

wavelength is higher than the film penetration depth, a condition satisfied in our $PdCoO_2$ thin films. By remembering that we are in a half-filling condition, i.e., the array periodicity is p=2W, where W is the ribbon width, the experimental reflectance of the ribbon-array patterned films can be obtained through the complex superposition of the ribbon covered and uncovered sapphire regions contributing to the Fresnel coefficient:

$$R(\omega) = \left| \frac{1}{2} r(\omega) + \frac{1}{2} r(\omega, \sigma_f = 0) \right|^2$$
 (2)

The calculated reflectances (black lines) for the $W = 1 \mu m$ and $W = 2 \,\mu\text{m}$ patterned films are represented in Fig. 3a, b, respectively in comparison to data (blue lines) and electromagnetic simulation (red lines, see above). In the calculation, we use both the experimental PdCoO₂ conductivity $\sigma_f(\omega)$ and the experimental dielectric function of the sapphire substrate $\varepsilon_c(\omega)$. A similar calculation for the PdCoO₂-air interface ($\varepsilon_c(\omega) = 1$) is shown in Fig. S2 of Supplementary Methods II. Equation (2) describes the reflectance behavior of our patterned films, showing a well defined dip (see Fig. 3), corresponding to the plasmon excitation at the PdCoO₂-sapphire interface. However, one can notice that the dip is much narrow with respect to the experimental one. Indeed, in the model equations, dissipation effects are only due to ohmic losses (contained in $\sigma_f(\omega)$), while in the actual situation other dissipation mechanisms are working including radiative losses¹⁴, shifting and broadening the dip in the reflectance curves. The experimental plasmon frequency ω_p can be estimated from reflectance data through the zero-crossing of its second derivative (see Fig. S1 of Supplementary Methods I). In Fig. 4 we thus represent the dispersion ω_p vs. the plasmon wavevector $q = \pi/W$ as determined by this method. Here, black points represent plasmon at the PdCoO₂-sapphire interface. ω_p approximately grows linearly in the probed wavevector range indicating that we are in the plasmon-polariton region, with a

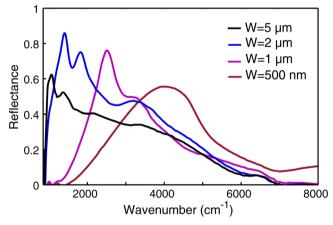


Fig. 2 Plasmonic reflectances obtained by removing both the sapphire phonon contributions below $-1000 \, \mathrm{cm}^{-1}$ and the high-frequency background above $-7000 \, \mathrm{cm}^{-1}$. Plasmon absorption hardens by decreasing width W and periodicity 2W, i.e. by increasing the corresponding wavevector $q = \pi/W$ as expected from theory.

slight deviation from the linear regime at $W = 2 \,\mu \text{m}$ and $W = 5 \,\mu \text{m}$ due to the variation of the sapphire dielectric function as induced by its phonon resonances. The calculation for the PdCoO₂-air interface is represented in Fig. S3 of Supplementary Methods II (black points). In this case, the point related to the maximum wavevector (corresponding to $W = 0.5 \,\mu \text{m}$) being out of the spectral region here measured has not been represented. Plasmon frequencies can be achieved from COMSOL simulation (using the same method developed for experimental data, see Supplementary Methods III), and they are represented in Fig. 4 as red stars at the PdCoO₂-sapphire interface (for the PdCoO₂-air interface, see Supplementary Methods II Fig. S3). These results show a very good agreement among data and COMSOL simulations. The plasmon frequency for a given ribbon width W (and periodicity 2W), can be obtained in the model, by the pole of the

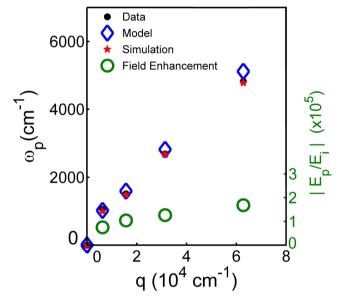
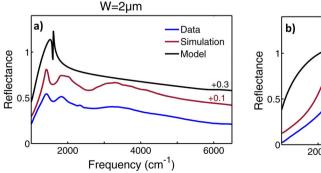


Fig. 4 Plasmon dispersion curves. Black points correspond to experimental plasmon frequencies, red stars to COMSOL simulation and blue diamonds to the model (Eq. (3) main text). Experimental, simulation and modeling dispersion well coincide at each wavevectors here measured. In the right axis the field enhancement factor $FE = |E_p/E_i|$ where E_p is the electric field at the plasmonic resonance and E_i the incident field, is plotted vs. the experimental wavevectors q. The strong field enhancement suggests a SEIRA device applications for PdCoO₂-based ribbon arrays⁷.



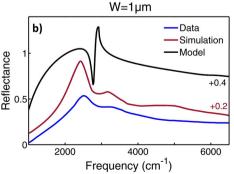


Fig. 3 Comparison among experimental (blue line), simulated (red line) and model (black line) reflectance of ribbon arrays with width $W=2 \mu m$ and $W=1 \mu m$ PdCoO₂. Model and simulated reflectances are shifted along the y-axis with an offset of 0.1 and 0.3 (a), and 0.2 and 0.4 (b), respectively. The dip in the reflectance spectra is related to plasmon excitations at the PdCoO₂-sapphire interface, the broad minima at a higher frequency to the PdCoO₂-air interface.

reflection coefficient of Eq. (1):

$$q_{\parallel}^{2}(\omega) = \varepsilon_{s}(\omega)q_{0}^{2} \left[1 - \frac{\varepsilon_{s}(\omega)}{\left(1 + \sigma_{f}(\omega)Z_{0}\right)^{2}} \right]$$
 (3)

Equation (3) applied for all $q = \pi/W$ allows the calculation of the plasmon frequencies ω_p , which are represented in Fig. 4 as blue diamonds for plasmons at the PdCoO₂-sapphire interface. Moreover, the model well reproduces the experimental dispersion for both interfaces. The plasmon electric field spatial distribution in the ribbon arrays for the $W = 2 \mu m$ is represented in Fig. S4 of Supplementary Methods III. A strong electric field can be observed near the ribbon edges at the PdCoO₂-sapphire interface, giving rise to a hot spot volume accessible for Surface Enhanced Infrared Spectroscopy (SEIRA) sensing applications⁷. From the field spatial distribution maps, one can calculate a parameter that cannot be easily measured experimentally, i.e., the plasmonic field enhancement (FE)³¹. $FE = |E_p/E_i|$ is defined as the electric field at the plasmon resonance E_p over the incident field E_i , both integrated over a circular area surrounding the ribbon section (see Fig. S4, Supplementary Methods III). Through electromagnetic simulation we obtain FE values (at the same experimental wavevectors of the dispersion curve) which are represented on the right axis of Fig. 4 by green circles. The strong field enhancement suggests a SEIRA device applications for PdCoO2-based ribbon arrays.

Conclusions

In conclusion, we measured and characterized the plasmonic excitations in the highly-conductive PdCoO2 metallic oxide. Four high-quality PdCoO₂ films, grown on sapphire and patterned with micro-ribbon arrays with different width (W) and periodicity (2W), were fabricated by lithography methods and optically investigated from terahertz to ultraviolet. Plasmon excitations appear as a dip in the reflectance measured for light polarization perpendicular to the ribbons. By extracting the experimental plasmon frequency ω_p from reflectance measurements, we were able to estimate the plasmon dispersion ω_p vs. the wavevector q. Electromagnetic simulation and a thin-film analytical model reproduce very well this dispersion. Near the ribbon edges at the PdCoO2-sapphire interface, we calculate a strong field enhancement due to plasmonic confinement, suggesting the use of PdCoO2-based plasmonic structures for sensing and nonlinear spectroscopy applications in the mid-infrared and terahertz spectral regions.

Methods

Synthesis of PdCoO2 film. Metallic delaffosite PdCoO2 films were grown by Molecular Beam Epitaxy technique on Al₂O₃ substrates. Starting with sapphire substrates oriented along the (001) axis, the PdCoO2 film grows under plasma oxygen at a pressure of 4×10^6 Torr. An annealing treatment in oxygen at 800 °C for 10 h allows us to improve the crystalline quality, decrease the resistivity and reduce the surface roughness²⁶. Films here used have a thickness of 100 nm, with a room temperature resistivity of $16\,\mu\Omega$ cm. Film quality was evaluated with different techniques (X-ray Diffraction, Rutherford Backscattering Spectroscopy, Atomic Force Microscopy, DC resistivity) as shown in Figs. S5 and S6 of Supplementary Methods IV.

Patterning of PdCoO2 film. The 100 nm thick PdCoO2 films on sapphire were treated with oxygen plasma cleaning (180 s, 100 W) to remove surface contaminants. Ribbons of 5, 2, and 1 μ m in width were fabricated recurring to electron beam lithography (EBL) system (Raith 150-two). A resist layer made of Polymethyl methacrylate (MicroChem Corp. PMMA A4) was spin coated on top of the samples and soft baked at 180 °C for 7 minutes. Then the PMMA layer was patterned via EBL, developed in a solution of Methyl Isobutyl Ketone and Isopropyl Alcohol (MIBK/IPA 1:3) for 30 s and stopped in IPA for other 30 s. Once developed, the samples were coated with a 50 nm thick chromium film by using an electron beam evaporator. Then, by soaking the sample in acetone, a hard mask for the subsequent dry etching step was formed. Indeed the pattern obtained through lift-off was transferred to the PdCoO2 layer by means of a plasma-enhanced reactive ion etching system (Sentech S1500) with argon gas. The etched depth and the side walls verticality were optimized by carefully tuning the process parameters (Ar 40 sccm, RF power 60 W, ICP power 200 W, temperature -5 °C, etching rate

 $10\,$ nm/min). Finally, the Cr-mask was removed in standard etchant solution (Chrome etch 18, Micro Resist Technology GmbH). A representative image of the final structures is shown in Fig. 1 Concurrently, 500 nm wide ribbons were fabricated via direct ion milling. A focused ion beam (FIB) system (FEI, dual-beam Helios Nanolab 650) working with Ga+ ions was operated for these purposes (current 200 pA, energy 30 keV). Prior to ion machining, a 200 nm thick Cr layer was deposited by electron beam evaporation. In this process the Cr film acted as a sacrificial mask, thus preventing charging effects and Ga+ implantation inside the PdCoO $_2$ structures. The residual Cr layer was dissolved in the standard etchant solution previously described.

Optical measurements. Measures in the THz-IR range were carried out with a Bruker Vertex 70v spectrometer coupled with a Hyperion 1000 microscope, scanning from 100 cm⁻¹ up to 8000 cm⁻¹ with a resolution of 4 cm⁻¹. In the IR-UV range the reflectance was measured with a JASCO V770 spectrometer, from 300 nm (3.3 × 10⁴ cm⁻¹) up to 3200 nm (3125 cm⁻¹) with a resolution of 1 nm. A set of THz/IR and NIR/UV polarizers have been used to control the electric field direction with respect to the ribbon array pattern. Morphological characterization was performed with the optical microscope of the JASCO NRS5100 Raman micro spectrometer, using an ×100 magnification optic. Analysis of the SEM images shows a 6% uncertainty in the ribbon width W and 2% uncertainty in the periodicity 2 W. These uncertainties have been used to calculate the corresponing error in the wavevector $q = \pi/W$. The PdCoO₂ and Al₂O₃ reflectance spectra were analyzed with the RefFit software²⁷, in order to extract the real and imaginary parts of both the dielectric function and the conductivity. On the real part of the optical conductivity we applied the f-sum rule³⁰ in order to extract the plasma frequency ω_{pl} of PdCoO₂ film. This results in a value of $16800 \pm 300 \text{ cm}^{-1}$. The optical conductivity can also be fitted using a Drude-Lorentz model with the RefFit software, obtaining a $\omega_{\rm pl}$ of $16000 \pm 100 \text{ cm}^{-1}$ in good agreement with that obtained by the f-sum rule.

Simulation. A finite-element method (FEM), implemented by means of COMSOL Multiphysics, was used to obtain the numerical simulations of the reflectance of films in the frequency range between 500 and 6500 cm $^{-1}$. The ribbon arrays were simulated by applying periodic boundary conditions to a unit cell of period p=2W, for a width of W=500 nm, 1, 2, and 5 μ m. As the input of the numerical simulation, we use the complex refractive indexes of PdCoO₂ and Al₂O₃ as obtained from the RefFit data analysis of the non-patterned film and bare substrate, respectively.

Data availability

The datasets generated and analyzed during the current study are not publicly available due to Department policy but are available from the corresponding author on reasonable request.

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Author contributions

All authors contributed extensively to the work presented in this paper. S.M., L.T., and S.L. designed the experiment. S.L., S.M., and S.O. supervised the work. G.R. and S.O. prepared and characterized the films. A.T. and V.A. fabricated ribbon patterning. L.T. and S.M. developed the theoretical model. S.T. developed and performed the numerical simulations. S.M., A.T., F.P., and M.Z. took the optical, and SEM images. S.M. and L.T. performed the optical measurements and analyzed the data. S.M. L.T., and S.L. prepared the original draft. All authors reviewed the manuscript. All authors have read and agreed to the published version of the manuscript.

Competing interests

The authors declare no competing interests.

Additional information

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